Search Notes			

Application/Control No.	ontrol No. Applicant(s)/Patent under Reexamination	
10/544,253	OHBAYASHI ET AL.	
Examiner	Art Unit	
HUYEN D. LE	2615	

	SEAR	CHED	
Class	Subclass	Date	Examiner
381	113, 116, 174, 175, 190, 191	9/14/2007	HL
381	369		HL
367	170		HL
367	181		HL.
367	140		HL
310	322		HL
310	334		HL

INT	INTERFERENCE SEARCHED		
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